

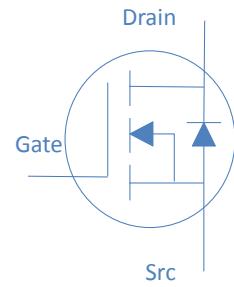
20V N-Ch Power MOSFET
Feature

- ◇ High Speed Power Switching, Logic Level
- ◇ Enhanced Avalanche Ruggedness
- ◇ 100% UIS Tested, 100% Rg Tested
- ◇ Lead Free, Halogen Free

V_{DS}	20	V
$R_{DS(on),typ}$	$V_{GS}=4.5V$	36 mΩ
$R_{DS(on),typ}$	$V_{GS}=2.5V$	43 mΩ
$R_{DS(on),typ}$	$V_{GS}=1.8V$	58 mΩ
I_D (Silicon Limited)	3.6	A

Application

- ◇ Hard Switching and High Speed Circuit
- ◇ DC/DC in Telecoms and Industrial

SOT-23


Part Number	Package	Marking
HTJ450N02	SOT23	1Y

Absolute Maximum Ratings at $T_j=25^\circ C$ (unless otherwise specified)

Parameter	Symbol	Conditions	Value	Unit
Continuous Drain Current (Silicon Limited)	I_D	$T_A=25^\circ C$	3.6	A
		$T_A=100^\circ C$	2.9	
Drain to Source Voltage	V_{DS}	-	20	V
Gate to Source Voltage	V_{GS}	-	± 12	V
Pulsed Drain Current	I_{DM}	-	14	A
Power Dissipation	P_D	$T_A=25^\circ C$	1.04	W
Operating and Storage Temperature	T_J, T_{stg}	-	-55 to 150	°C

Absolute Maximum Ratings

Parameter	Symbol	Max	Unit
Thermal Resistance Junction-Ambient	$R_{\theta JA}$	120	°C/W

Electrical Characteristics at $T_j=25^\circ\text{C}$ (unless otherwise specified)
Static Characteristics

Parameter	Symbol	Conditions	Value			Unit
			min	typ	max	
Drain to Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}}=0\text{V}, I_D=250\mu\text{A}$	20	-	-	V
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{GS}}=V_{\text{DS}}, I_D=250\mu\text{A}$	0.40	0.75	1.2	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=16\text{V}, T_j=25^\circ\text{C}$	-	-	1	μA
		$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=16\text{V}, T_j=125^\circ\text{C}$	-	-	10	
Gate to Source Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm 12\text{V}, V_{\text{DS}}=0\text{V}$	-	-	± 100	nA
Drain to Source on Resistance	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}}=4.5\text{V}, I_D=3.5\text{A}$	-	36	45	$\text{m}\Omega$
		$V_{\text{GS}}=2.5\text{V}, I_D=2\text{A}$	-	43	60	
		$V_{\text{GS}}=1.8\text{V}, I_D=1\text{A}$	-	58	85	
Transconductance	g_{fs}	$V_{\text{DS}}=5\text{V}, I_D=3.5\text{A}$	-	5	-	S

Dynamic Characteristics

Input Capacitance	C_{iss}	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=10\text{V}, f=1\text{MHz}$	-	355	-	pF
Output Capacitance	C_{oss}		-	56	-	
Reverse Transfer Capacitance	C_{rss}		-	40	-	
Total Gate Charge	Q_g	$V_{\text{DD}}=10\text{V}, I_D=3.5\text{A}, V_{\text{GS}}=4.5\text{V}$	-	4.6	-	nC
Gate to Source Charge	Q_{gs}		-	0.66	-	
Gate to Drain (Miller) Charge	Q_{gd}		-	1.5	-	
Turn on Delay Time	$t_{\text{d}(\text{on})}$		-	8	-	
Rise time	t_r	$V_{\text{DD}}=10\text{V}, I_D=1\text{A}, V_{\text{GS}}=4.5\text{V}, R_G=6\Omega,$	-	10	-	ns
Turn off Delay Time	$t_{\text{d}(\text{off})}$		-	20	-	
Fall Time	t_f		-	15	-	

Reverse Diode Characteristics

Diode Forward Voltage	V_{SD}	$V_{\text{GS}}=0\text{V}, I_F=2\text{A}$	-	1.2	V
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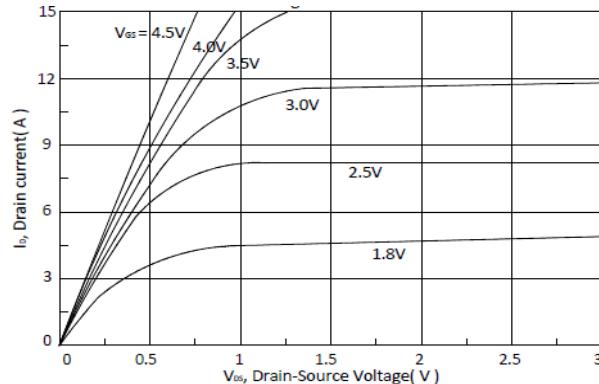
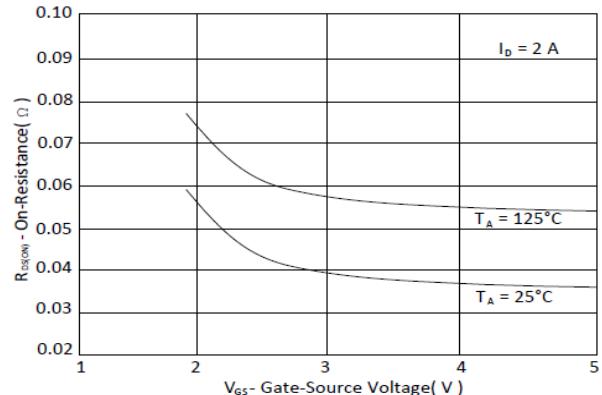
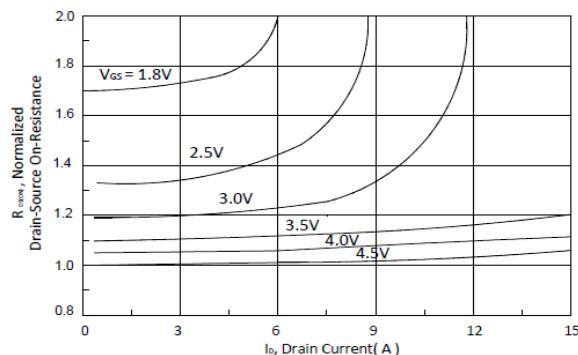
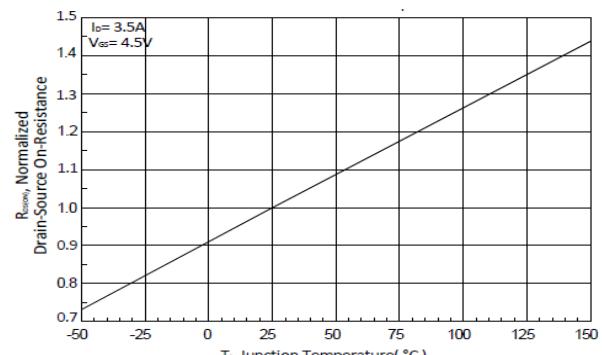
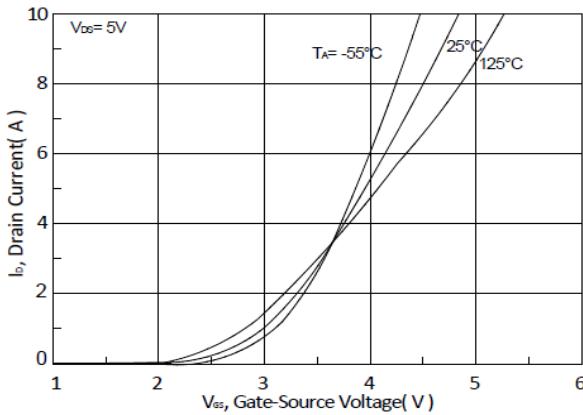
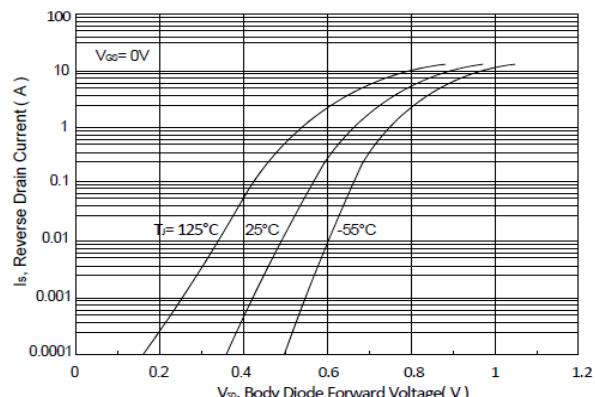
Fig 1. Typical Output Characteristics

Figure 2. On-Resistance vs. Gate-Source Voltage

Figure 3. On-Resistance vs. Drain Current and Gate Voltage

Figure 4. Normalized On-Resistance vs. Junction Temperature

Figure 5. Typical Transfer Characteristics

Figure 6. Typical Source-Drain Diode Forward Voltage


Figure 7. Typical Gate-Charge vs. Gate-to-Source Voltage

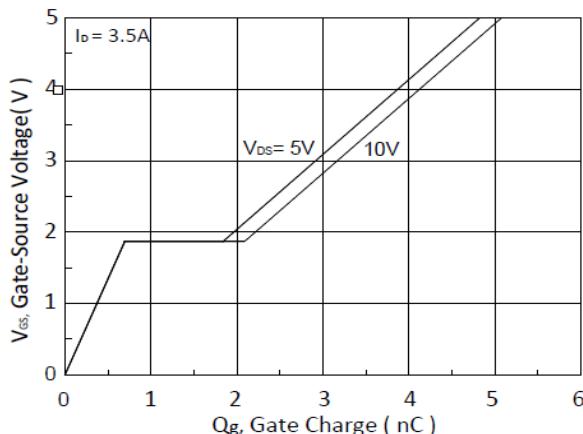


Figure 8. Typical Capacitance vs. Drain-to-Source Voltage

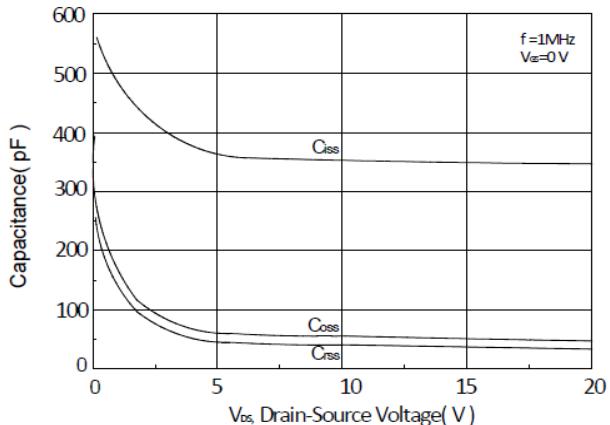


Figure 9. Maximum Safe Operating Area

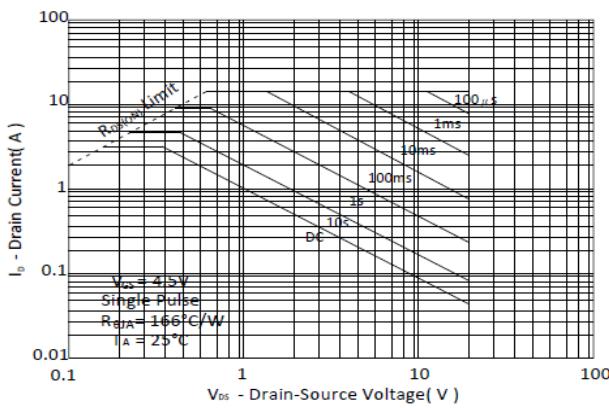


Figure 10. Maximum Drain Current vs. Case Temperature

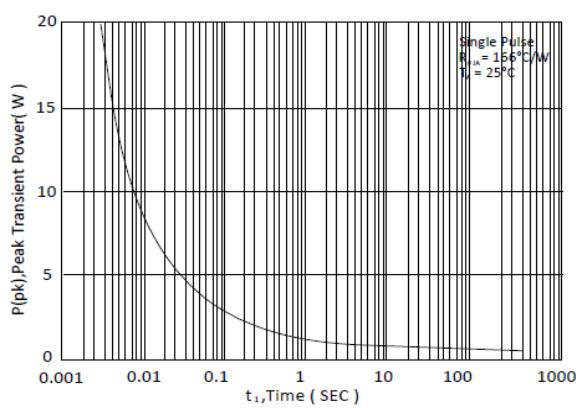
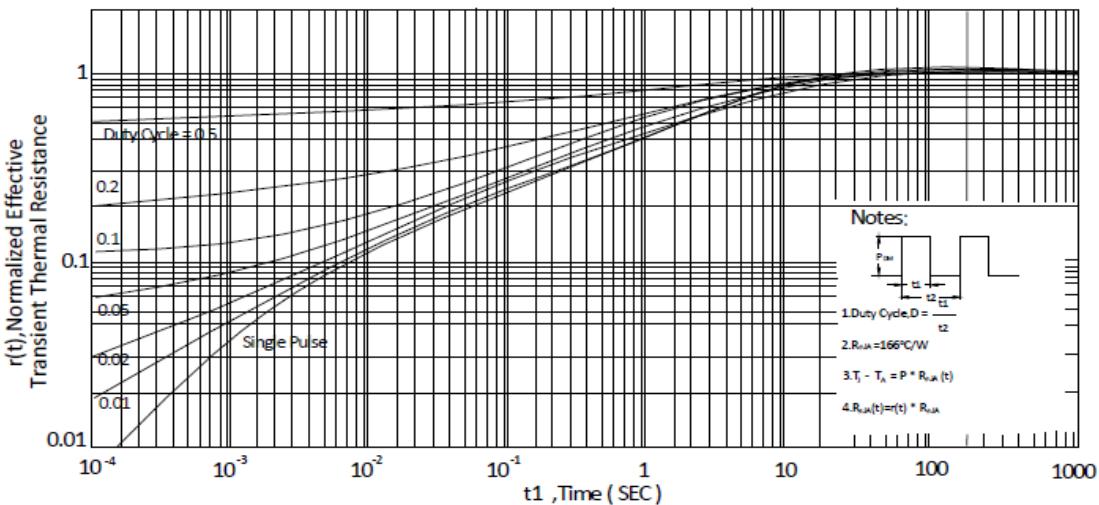
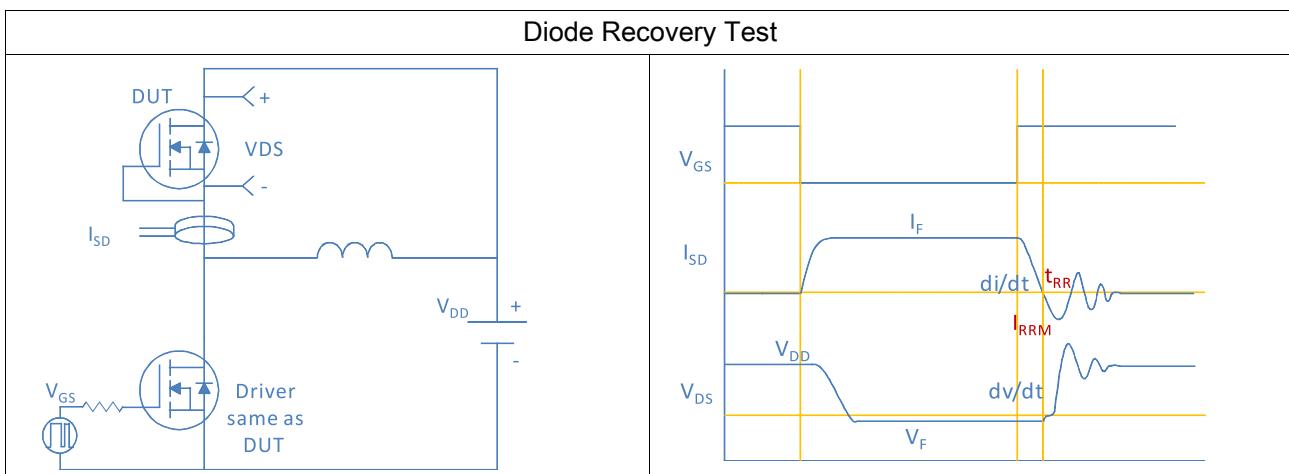
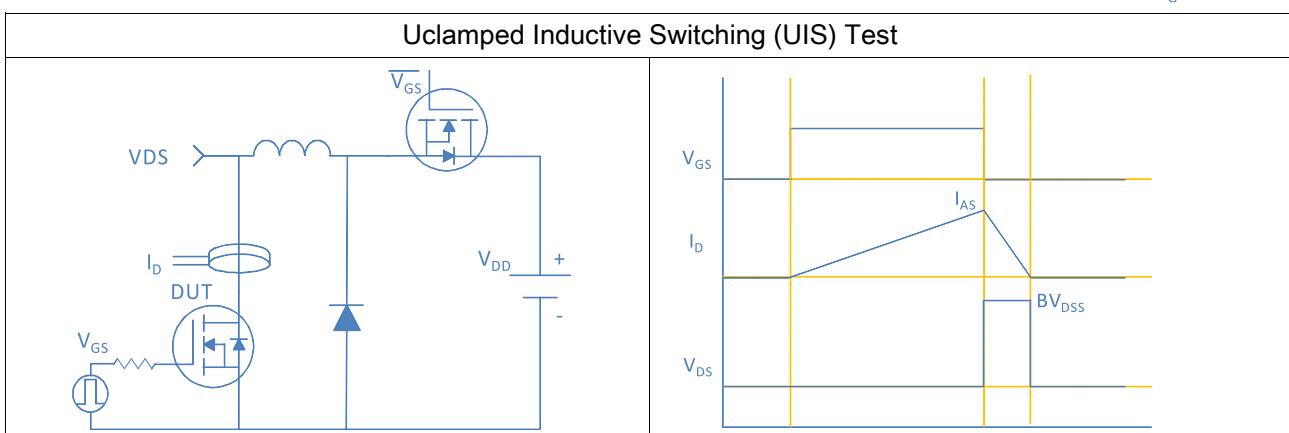
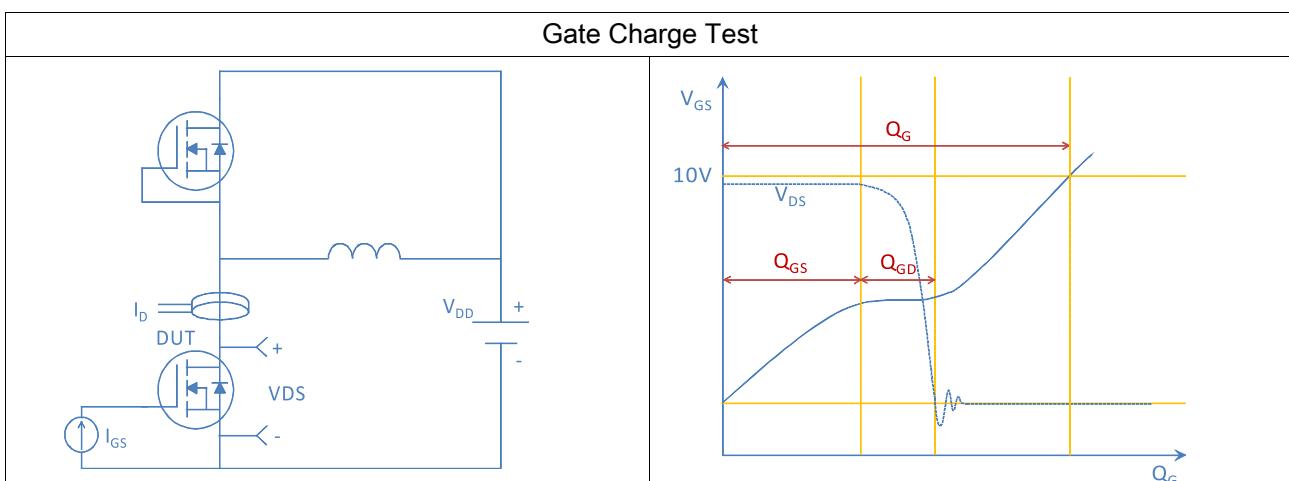
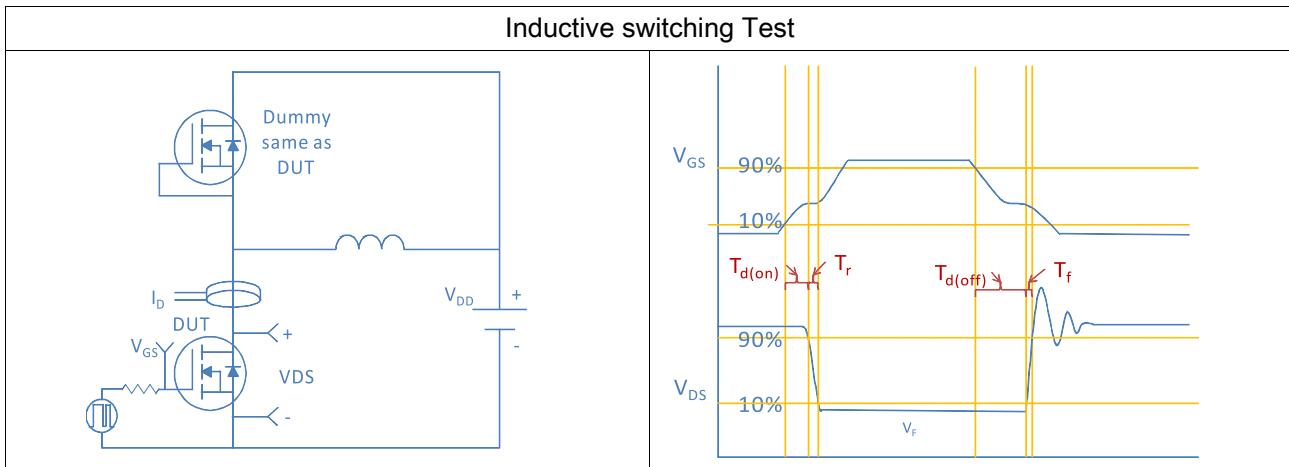
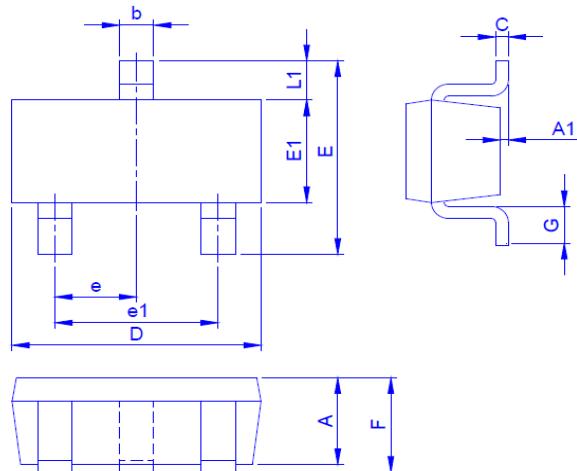


Figure 11. Normalized Maximum Transient Thermal Impedance, Junction-to-Ambient





Package Outline
SOT-23, 3leads

Dimension in mm

Dimension	A	A1	b	C	D	E	E1	e	e1	F	G	L1
Min.	0.70	0	0.3	0.08	2.80	2.25	1.2	0.90		0.80	0.3	0.50
Typ.					2.90			0.95	1.9			
Max.	1.15	0.1	0.5	0.20	3.02	3.00	1.7	1.00		1.25	0.6	0.75